Notice of References Cited Application/Control No. 10/684,503 Examiner Richard Bueker Applicant(s)/Patent Under Reexamination SAKAMOTO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,796,562	01-1989	Brors et al.	118/725
*	В	US-5,273,588	12-1993	Foster et al.	118/723E
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0	"				
	P					
	Q			•		
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	Lee et al, Thin solid Films 262 (1995) 39-45.
	٧	Keenan, General College Chemistry, Harper & Row, 1957, pages132-133.
	w	Powell et al., Vapor Deposition, John Wiley & Sons, 1967, pages 274-275 and 296-297.
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.